

Table of Contents

Preface	vii
Editorial Notes	xiii
EPDIC Award	xv

VOLUME I

I. METHOD DEVELOPMENT AND APPLICATION

I.1 Determination of Crystal Structure

<i>R. B. Von Dreele, P. L. Lee, Y. Zhang</i> Protein polycrystallography	3
---	---

<i>T. Bataille, N. Mahé, E. Le Fur, J.-Y. Pivan, D. Louër</i> Using the parallel tempering algorithm to overcome complex problems in structure determination of inorganic materials with laboratory X-rays	9
--	---

<i>E. Y. Cheung, K. D. M. Harris</i> Molecular crystal structures from powder X-ray diffraction techniques	15
---	----

<i>B. Peplinski, D. M. Töbrens, W. Kockelmann, R. M. Ibberson</i> On the uncertainty of lattice parameters refined from neutron diffraction data	21
---	----

I.2 Qualitative and Quantitative Phase Analysis

<i>B. Peplinski, P. Köcher, G. Kley</i> Application of the Rietveld method to the severely superimposed diffraction patterns of technical products containing a large number of solid solution phases	29
---	----

<i>M. Kotrlý</i> Application of X-ray diffraction in forensic science	35
--	----

I.3 Analysis of Microstructure and Macrostress

I.3.1 Residual Stresses

<i>U. Welzel, S. Fréour, A. Kumar, E. J. Mittemeijer</i> Diffraction stress analysis of grain interaction in polycrystalline materials	43
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<i>A. C. Vermeulen</i> Accurate absolute peak positions for multiple $\{hkl\}$ residual stress analysis by means of misalignment corrections	49
<i>A. Kumar, U. Welzel, E. J. Mittemeijer</i> Diffraction stress analysis of strongly fibre-textured gold layers	55
<i>P. Zanola, D. Benedetti, E. Bontempi, V. Villa, G. Baronio, M. Tosti, R. Roberti, L. E. Depero</i> Residual stress measurement of gold artefacts by Debye ring analysis	61
<i>M. Dopita, D. Rafaja</i> X-ray residual stress measurement in titanium nitride thin films	67
1.3.2 Line Broadening Analysis	
<i>R. Kužel</i> Dislocation line broadening	75
<i>N. Armstrong, M. Leoni, P. Scardi</i> Considerations concerning Wilkens' theory of dislocation line-broadening	81
<i>A. Borbély, A. Révész, I. Groma</i> Momentum method applied to evaluation of size and strain in ball-milled iron	87
<i>J. Gubicza, N. H. Nam, K. Máthi, V. V. Stolyarov</i> Microstructure of severely deformed metals from X-ray line profile analysis	93
<i>I. C. Dragomir, G. A. Castello-Branco, G. Ribárik, H. Garmestani, T. Ungár, R. L. Snyder</i> Burgers Vector Populations in hot rolled titanium determined by X-ray Peak Profile Analysis	99
<i>M. Kerber, E. Schafner, P. Hanak, G. Ribárik, S. Bernstorff, T. Ungár, M. Zehetbauer</i> Spatial fluctuations of the microstructure during deformation of Cu single crystals	105
<i>M. Leoni, G. De Giudici, R. Biddau, M. D'Incau, P. Scardi</i> Analysis of polydisperse ball-milled fluorite powders using a full pattern technique	111
<i>A. Leineweber, E. J. Mittemeijer</i> Anisotropic microstrain broadening due to compositional inhomogeneities and its parametrisation	117

A. Boule, R. Guinebretière, A. Dauger

X-ray diffraction from epitaxial thin films: an analytical expression of the line profiles accounting for microstructure 123

E. Schafler, K. Nyilas, S. Bernstorff, L. Zeipper, M. Zehetbauer, T. Ungár

Microstructure of post deformed ECAP-Ti investigated by Multiple X-Ray Line Profile Analysis 129

K. Nyilas, H. Couvy, P. Cordier, T. Ungár

The dislocation-structure and crystallite-size in forsterite (olivine) deformed at 1400 °C by 11 GPa 135

S. Daniš, V. Holý

Diffuse X-ray scattering from GaN/SiC (0001) thin films 141

Z. Kaszukur

Test of applicability of some powder diffraction tools to nanocrystals 147

S. V. Cherepanova, S. V. Tsybulya

Influence of coherent connection of crystalline blocks on the diffraction pattern of nanostructured materials 155

I.4 Texture

R. A. Schwarzer

Automated Crystal Orientation Measurement by backscatter Kikuchi diffraction 163

S. Battaglia, L. Leoni

A simple technique for correcting diffraction intensities for the effects of preferred orientation in calcite samples 169

G. Gómez-Gasga, T. Kryshab, J. Palacios-Gómez, A. de Ita de la Torre

Influence of extinction phenomenon on determination of the orientation distribution function 175

II. INSTRUMENTAL

R. Gilles, M. Hoelzel, M. Schlapp, F. Elf, B. Krimmer, H. Boysen, H. Fuess

First test measurements at the new structure powder diffractometer (SPODI) at the FRM-II 183

J. Peters, K. Lieutenant, D. Clemens, F. Mezei

EXED – the new Extreme Environment Diffractometer at the Hahn-Meitner-Institut Berlin 189

<i>A. Wannberg, M. Grönros, A. Møllergård, L.-E. Karlsson, R. G. Delaplane, B. Lebeck</i> R2D2: a new neutron powder diffractometer at NFL	195
<i>Y. N. Choi, S. A. Kim, S. K. Kim, S. B. Kim, C. H. Lee, P. Mikula, M. Vrána</i> Bent perfect crystal monochromator at the monochromatic focusing condition	199
<i>P. Mikula, M. Vrána, V. Wagner</i> Multiple-reflection neutron bent-perfect-crystal (BPC) monochromator	205
<i>L. Almásy, A. Len, M. Markó, E. Rétfalvi</i> Wavelength calibration in conventional SANS setup with a mechanical velocity selector	211
<i>A. M. Balagurov, G. D. Bokuchava, E. S. Kuzmin, A.V. Tamonov, V. V. Zhuk</i> Neutron RTOF diffractometer FSD for residual stress investigation	217

III. SOFTWARE DEVELOPMENT

<i>D. Louër, A. Boultif</i> Indexing with the successive dichotomy method, DICVOL04	225
<i>B. Hinrichsen, R. E. Dinnebier, M. Jansen</i> Powder3D: An easy to use program for data reduction and graphical presentation of large numbers of powder diffraction patterns	231
<i>J. Birkenstock, R. X. Fischer, T. Messner</i> BRASS, the Bremen Rietveld analysis and structure suite	237
<i>M. Casas-Cabanas, J. Rodríguez-Carvajal, M. R. Palacín</i> FAULTS, a new program for refinement of powder diffraction patterns from layered structures	243
<i>M. Leoni, T. Confente, P. Scardi</i> PM2K: a flexible program implementing Whole Powder Pattern Modelling	249
<i>D. M. Töbrens</i> Calculating the peak shape of axially focussing powder diffractometers	255

VOLUME II

IV. MATERIALS

IV.1 Thin Layers

<i>R. Guinebretière, A. Boulle, O. Masson, A. Dauger</i> X-ray scattering from interface dislocations in highly mismatched oxide epitaxial films ...	263
<i>R. Mirchev, V. Antonov, I. Iordanova, P. J. Kelly</i> Influence of magnetron sputtering conditions on the parameters of TiN coatings on steel substrates	269
<i>P. Zanola, E. Bontempi, M. Gelfi, M. Tosti, R. Roberti, L. E. Depero</i> Structural and microstructural characterisation of ZrN coatings for decorative applications	275
<i>S. R. Lukić, D. M. Petrović, G. R. Štrbac, D. D. Štrbac</i> Chalcogenide films on glass substrate as attenuators of X-ray radiation	281
<i>T. Kryshtab, J. Palacios Gómez, M. Mazin</i> Effect of annealing conditions on structural transformation of ZnS thin film	287
<i>I. Yu. Molina, L. M. Plyasova, S. V. Cherepanova, E. R. Savinova, G. A. Tsirlina</i> Electrocrystallization of Pt layers onto Au substrates; an X-ray diffraction study	293
<i>W. Fischer, G. Blass</i> Residual stress mapping in the zirconia electrolyte layer of a high-temperature solid oxide fuel cell	299
<i>M. Jergel, M. Ožvold, R. Senderák, Š. Luby, E. Majková</i> Ultrashort period Cu/Si and Ni/C multilayers for X-ray mirrors	305
IV.2 Nanocrystalline Materials	
<i>T. Ungár</i> Microstructure of nanocrystalline materials studied by powder diffraction	313
<i>M. Šlouf, R. Kužel, Z. Matěj</i> Preparation and characterization of isometric gold nanoparticles with pre-calculated size	319
<i>J. Oddershede, K. Ståhl</i> Bulk characterization of multiwall carbon nanotubes	325

<i>S. Stel'makh, E. Grzanka, Y. Zhao, W. Palosz, B. Palosz</i> Neutron diffraction studies of the atomic vibrations of bulk and surface atoms of nanocrystalline SiC	331
<i>E. Grzanka, S. Gierlotka, S. Stelmakh, B. Palosz, T. Strachowski1, A. Swiderska-Sroda, G. Kalisz, W. Lojkowski, F. Porsch</i> Phase transition in nanocrystalline ZnO	337
IV.3 Metals and Alloys	
<i>Yu. V. Taran, M. R. Daymond, E. C. Oliver, J. Schreiber</i> Study of martensitic transformation in fatigued stainless steel by neutron diffraction stress analysis	345
<i>A. Leineweber, E. J. Mittemeijer</i> The evaluation of the kinetics of ordering processes in Ni _{1+δ} Sn ($\delta = 0.35, 0.50$) by X-ray powder diffraction	351
<i>P. Lukáš, O. Muránsky, J. Polák, P. Jenčuš</i> In situ neutron diffraction study of the low cycle fatigue of the α - γ duplex stainless steel	357
<i>P. Strunz, J. Zrník, T. Seliga, H. J. Penkalla</i> SANS investigation of precipitate microstructure in nickel-base superalloys Waspaloy and DT750	363
<i>M. Čerňanský, N. Ganev, J. Barcal, J. Drahoukoupil, K. Kolařík</i> Diffraction analysis of iron materials after surface machining	369
<i>S. J. Skrzypek, J. Jelenkowsky, T. Borowski, W. Ratuszek, T. Wierzchoń</i> Non-destructive phase analysis and residual stresses measurement using grazing angle X-ray diffraction geometry	375
<i>L. Balogh, J. Gubicza, R. J. Hellmig, Y. Estrin, T. Ungár</i> Thermal stability of the microstructure of severely deformed copper	381
<i>D. Visser, W. Kockelmann, P. Hallebeek, J. Veerkamp, W. Krook</i> Archaeometric study of Dutch Tin-Lead spoon fragments from Amsterdam: 1500 - 1775 AD. A neutron scattering study	387
<i>J. Šaroun, J. Kočík, E. Garcia-Matres, O. Muránsky, P. Strunz</i> Characterisation of radiation-induced precipitates in reactor pressure vessel steels	393

<i>N. Mattern, J. Sakowski, C. Baehtz</i> Structure analysis of NiZr ₂ in reciprocal and real space	399
<i>A. Teresiak, A. Gebert, M. Savyak, N. Mattern, M. Uhlemann</i> In situ high temperature XRD studies of the crystallisation of melt-spun Mg ₇₇ Ni ₁₈ Y ₅	405
<i>R. Černý, G. Renaudin, Y. Tokaychuk, V. Favre-Nicolin</i> Complex intermetallic compounds in the Mg-Ir system solved by powder diffraction	411

IV.4 Minerals and Inorganics

IV.4.1 Structural Changes, Non-Ambient Conditions

<i>M. Merlini, M. Gemmi, G. Artioli</i> Low temperature SR-XRPD study of åkermanite-gehlenite solid solution	419
<i>W. Oueslati, H. Ben Rhaïem, M. S. Karmous, S. Naaman, A. Ben Haj Amara</i> Study of the structural evolution and selectivity of Wyoming montmorillonite in relation with the concentration of Cu ²⁺ and Ni ²⁺	425
<i>M. S. Karmous, H. Ben Rhaïem, S. Naamen, W. Oueslati, A. Ben Haj Amara</i> The interlayer structure and thermal behavior of Cu and Ni montmorillonites	431
<i>M. Dapiaggi, G. Artioli, C. Mazzocchia, M. Merlini</i> Structural characterisation of high-temperature K-exchanged sodalite	437
<i>T. G. Berger, A. Leineweber, E. J. Mittemeijer, M. Knapp</i> A time-resolved X-ray powder diffraction method to trace the decomposition of PdB _y solid solutions	443
<i>T. Liapina, A. Leineweber, E. J. Mittemeijer, M. Knapp, C. Baehtz, Z. Q. Liu, K. Mitsuishi, K. Furuya</i> γ'-Fe ₄ N formation in decomposing ε-Fe ₃ N: A powder diffraction study using synchrotron radiation	449
<i>M. Novotna, J. Maixner</i> X-ray powder diffraction study of leucite crystallization	455
<i>M. Fábíán, E. Sváb, Gy. Mészáros, L. Kószegi, L. Temleitner, E. Veress</i> Neutron diffraction structure study of borosilicate based matrix glasses	461
<i>S. G. Vasilovsky, V. V. Sikolenko, A. I. Beskrovny, A. V. Belushkin, I. N. Flerov, A. Tressaud, A. M. Balagurov</i> Neutron diffraction studies of temperature induced phase transitions in Rb ₂ KFeF ₆ elpasolite	467

IV.4.2 Determination of Crystal Structure

T. Trendafilova, D. Kovacheva, K. Petrov, A. Hewat

Cation distribution in $\text{Li}_2\text{M(II)Sn}_3\text{O}_8$, M(II)=Mg, Co, Fe 475

T. Aitasalo, J. Hölsä, T. Laamanen, M. Lastusaari, L. Lehto, J. Niittykoski, F. Pellé

Crystal structure of the monoclinic $\text{Ba}_2\text{MgSi}_2\text{O}_7$ persistent luminescence material 481

H. Palancher, C. Pichon, J. L. Hodeau, J. F. Bézar, J. Lynch, B. Rebours, J. Rodriguez-Carvajal

Cation distributions in fully hydrated Sr- and Rb- bicationic zeolites: an X-ray anomalous powder diffraction study 487

S. Ferrari, A. F. Gualtieri, G. H. Grathoff, M. Leoni

Model of structure disorder of illite: preliminary results 493

S. Naamen, H. Ben Rhaïem, M. S. Karmous, A. Ben Haj Amara

XRD study of the stacking mode of the nacrite/alkali halides complexes 499

N. Perchiazzi

Crystal structure determination and Rietveld refinement of roasite and mcguinnessite 505

R. Minikayev, W. Paszkowicz, F. Firszt, H. Męczyńska, A. Marasek

Rietveld analysis of polytypic $\text{Zn}_{1-x}\text{Mg}_x\text{Se}$ and $\text{Zn}_{1-x-y}\text{Mg}_x\text{Be}_y\text{Se}$ solid solutions 511

P. Friedel, J. Bergmann, R. Kleeborg, G. Schubert

A proposition for the structure of ammonium hydrogen (acid) urate from uroliths 517

M. Ermrich, F. Peters

X-ray powder diffraction data of synthetic β -tricalcium phosphate 523

S. Vratislav, M. Dlouhá, V. Bosáček

Distribution of sodium cations and chemisorbed methyl groups in the structure of NaX, and NaLSX zeolite catalysts by powder neutron diffraction and ^{13}C NMR 529

IV.4.3 Determination of Magnetic Structure, Magnetic Materials

S. A. Ivanov, S.-G. Eriksson, R. Tellgren, H. Rundlöf, M. Tssegai

Structural and magnetic study of magnetoelectric perovskite $\text{Sr}_2\text{CoMoO}_6$ 537

V. Kavečanský, M. Mihalik, S. Matáš, Z. Mitróová, M. Lukáčová

Crystal structure and magnetism of $\text{Pr}[\text{Fe}(\text{CN})_6] \cdot 4\text{D}_2\text{O}$ 543

IV.4.4 Microstructure, Phase Analysis

<i>J. M. Amigó, F. J. Serrano, M. A. Kojdecki, J. Bastida, V. Esteve, M. M. Reventós</i> Microstructure of crystalline phases in electrotechnical porcelains	551
<i>P. Derollez, A. Hédoux, Y. Guinet, J. Lefebvre, M. Descamps, O. Hernandez</i> Micro(nano)structure of the glacial state in triphenyl phosphite (TPP)	557
<i>M. Koivisto, E. Suihko, V.-P. Lehto</i> Correlation between texture and tableting properties of some pharmaceutical tablets	563
<i>L. Bucio, I. A. Belío-Reyes, J. A. Rodríguez, M. N. Orta, J. Arenas-Alatorre, C. Magaña, R. Velázquez</i> Incrustation of precious stones in dental apatite	569
<i>G. Vanhoyland, D. Mondelaers, H. Van den Rul, J. D'Haen, L. C. Van Poucke, J. Mullens</i> Microstructural analysis of ZnO from different aqueous synthesis routes	575
<i>Z. K. Heiba, Sameh Ahmed, Ali Abo-Shama, Karimat El-Sayed</i> The effect of Al and Gd doping on the structure, microstructure and thermal expansion of gallium nitride (GaN)	581
<i>A. G. De la Torre, A. Cabeza, E. R. Losilla, M. A. G. Aranda</i> Quantitative phase analysis of ordinary Portland cements using synchrotron radiation powder diffraction	587
IV.5 Organic Materials	
<i>C. Platteau, J. Lefebvre, S. Hemon, F. Affouard, J. F. Willart, P. Derollez</i> <i>Ab initio</i> structure determination of two anhydrous forms of α -lactose by powder X-ray diffraction	595
<i>M. Ramírez-Cardona, J. C. Escamilla-Casas, M. A. Cuevas-Diarte, I. Barajas-Rosales</i> Structure determination of 1-pentanol ($C_5H_{12}O$) at 183 K	601
<i>J. T. Bonarski, W. Olek</i> Crystallographic texture changes of wood due to air parameters variations	607
<i>J. Hašek</i> Poly(ethylene glycol) interactions with proteins	613
Author Index	xxvii